SN54ALS1245A, SN74ALS1245A OCTAL BUS TRANSCEIVERS WITH 3-STATE OUTPUTS SDAS245A – DECEMBER 1982 – REVISED JANUARY 1995

- Bidirectional Bus Transceivers in High-Density 20-Pin Packages
- Low-Power Versions of 'ALS245 Series
- 'ALS1245 Series Is Identical to 'ALS1645 Series
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

description

These octal bus transceivers are designed for asynchronous two-way communication between data buses. These devices transmit data from the A bus to the B bus or from the B bus to the A bus, depending on the logic level at the direction-control (DIR) input. The output-enable (\overline{OE}) input can be used to disable the device so the buses are effectively isolated.

The SN54ALS1245A is characterized for operation over the full military temperature range of -55° C to 125° C. The SN74ALS1245A is characterized for operation from 0°C to 70°C.

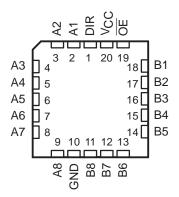
FUI	NCTIO	ON T	ABLE

INP	UTS	OPERATION			
OE	DIR	OPERATION			
L	L	B data to A bus			
L	Н	A data to B bus			
Н	Х	Isolation			

SN54ALS1245A .	J PACKAGE
SN74ALS1245A D	DW OR N PACKAGE
(TOP V	/IEW)

	(,	
DIR A1 A2 A3 A4 A5 A6 A7	[2] [3] [4] [5] [6] [7] [8]	U 20 19 18 17 16 15 14 13	<u>V_{CC}</u> OE B1 B2 B3 B4 B5
A7 A8 GND	9	13 12 11] В6] В7] В8

SN54ALS1245A . . . FK PACKAGE (TOP VIEW)

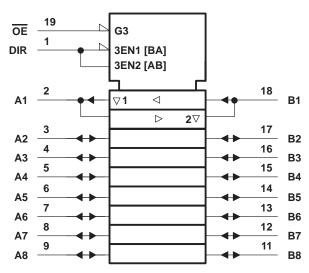


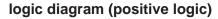


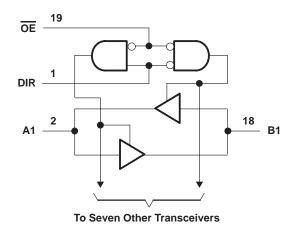
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logic symbol[†]







[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[‡]

Supply voltage, V _{CC}	
Input voltage, V _I : All inputs	
I/O ports	5.5 V
Operating free-air temperature range, T _A : SN54ALS1245A	-55°C to 125°C
SN74ALS1245A	0°C to 70°C
Storage temperature range	-65°C to 150°C

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		SN54ALS1245A		SN74ALS1245A			UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.7			0.8	V
ЮН	High-level output current			-12			-15	mA
IOL	Low-level output current			8			16	mA
TA	Operating free-air temperature	-55		125	0		70	°C



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PARAMETER		TEST CONDITIONS		SN5	SN54ALS1245A			SN74ALS1245A			
				MIN	түр†	MAX	MIN	TYP [†]	MAX	UNIT	
VIK		V _{CC} = 4.5 V,	lı = – 18 mA			-1.5			-1.5	V	
		V _{CC} = 4.5 V to 5.5 V,	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2	2		V _{CC} -2	2			
\/			$I_{OH} = -3 \text{ mA}$	2.4	3.2		2.4	3.2		v	
VOH		V _{CC} = 4.5 V	I _{OH} = -12 mA	2						V	
			I _{OH} = -15 mA				2				
Vai		V _{CC} = 4.5 V	IOT= 8 WY		0.25	0.4		0.25	0.4	V	
VOL			I _{OL} = 16 mA					0.35	0.5		
I.	Control inputs		VI = 7 V			0.1			0.1	~ ^	
II.	A or B ports	V _{CC} = 5.5 V	V _I = 5.5 V			0.1			0.1	mA	
I	Control inputs		<u>)</u>			20			20		
ΙΗ	A or B ports‡	$V_{CC} = 5.5 V,$	V ₁ = 2.7 V			20			20	μA	
1	Control inputs		\/. 0.4.\/			-0.1			-0.1	mA	
ΊL	A or B ports‡	$V_{CC} = 5.5 V,$	$V_{\rm CC} = 5.5 \text{ V}, \qquad V_{\rm I} = 0.4 \text{ V}$			-0.1			-0.1	mA	
۱ ₀ §		V _{CC} = 5.5 V,	V _O = 2.25 V	-20		-112	-30		-112	mA	
			Outputs high		21	33		21	30		
ICC		V _{CC} = 5.5 V	Outputs low		23	36		23	33	mA	
			Outputs disabled		25	40		25	36		

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

[†] All typical values are V_{CC} = 5 V, T_A = 25°C. [‡] For I/O ports, the parameters I_{IH} and I_{IL} include the off-state output current. § The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS}.

switching characteristics (see Figure 1)

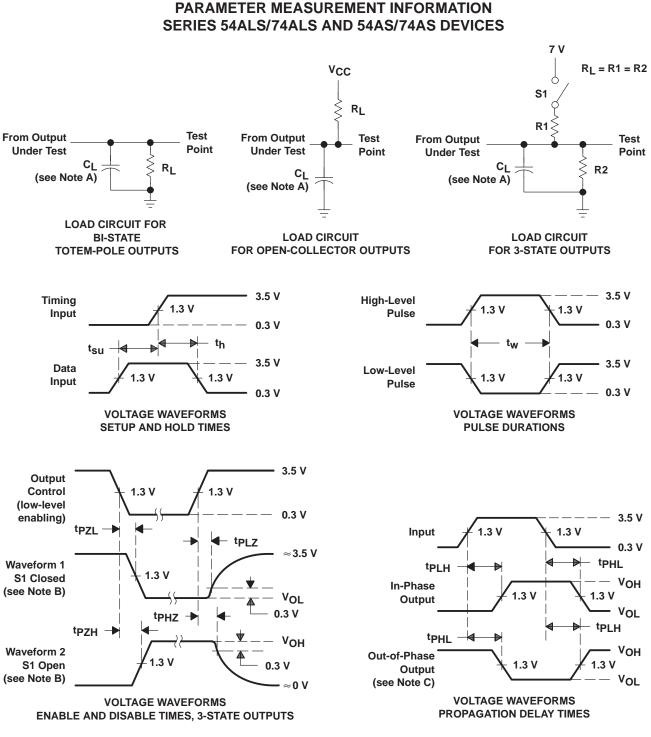
PARAMETER	FROM (INPUT)	$\label{eq:constraint} \begin{array}{c} V_{CC} = 4.5 \ V \ to \ 5.5 \ V, \\ C_L = 50 \ pF, \\ R1 = 500 \ \Omega, \\ R2 = 500 \ \Omega, \\ (OUTPUT) \\ T_A = MIN \ to \ MAX \\ \end{array}$		CL = 50 pF, R1 = 500 Ω, R2 = 500 Ω, T _A = MIN to			UNIT
			SN54ALS1245A		SN74ALS1245A		
			MIN	MAX	MIN	MAX	
tPLH	A or B	or B B or A	2	19	2	13	ns
^t PHL			2	15	2	13	115
^t PZH	OE	A or B	8	30	8	25	ns
^t PZL	UE		8	29	8	25	115
^t PHZ	OE	A or B	2	14	2	12	ns
^t PLZ	UE		3	30	3	18	113

For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



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NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control. C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: $PRR \le 1$ MHz, $t_f = t_f = 2$ ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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